LFPAK
The Toughest Power-SO8
The evolution of Power MOSFET packages

Typical TO220 construction

TO220 is the ‘original’ through-hole power package. It is suitable for through-hole mounting and low-cost wave soldering. It also provides very low thermal resistances when mounted to a suitable heatsink.

**Benefits**
- Devices are ideal for through-hole PCB assembly & wave soldering
- Compatible with a wide variety of heat-sinking techniques
- Low $R_{th(j-a)}$ when mounted to a suitable heatsink

**Limitations**
- Bond wires give significant package resistance, high inductance, poor $I_D(\text{max})$, and poor thermal performance unless a heatsink is used
- Physical size and weight

Typical D2PAK construction

D2PAK is a surface-mount variant of the TO220 package. The MOSFET is assembled in the same manner to TO220, but the DRAIN tab and the GATE & SOURCE pins are modified to make the device suitable for surface mount and reflow soldering directly to a PCB.

**Benefits**
- Uses the PCB as a heatsink
- Compatible with pick & place machines and reflow soldering
- Lower package resistance & inductance than TO220 since the DRAIN connection is made via the power-tab instead of TO220 lead

**Limitations**
- Heat dissipation through the PCB may be limited compared to a heatsink
- Bond wires give high package resistance, high inductance & poor $I_D(\text{max})$ when compared to an LFPAK device

Typical DPAK construction

DPAK construction is similar to D2PAK, however the DPAK package outline is approximately 65mm² compared to D2PAK 150mm².

**Benefits**
- Uses the PCB as a heatsink
- Compatible with pick & place machines & reflow soldering
- Reduced PCB footprint when compared to D2PAK

**Limitations**
- Smaller silicon size means relatively high $R_{D\text{son}}$ values
- Fewer bond wires give high package resistance, high inductance & poor $I_D(\text{max})$ when compared to D2PAK
Loss Free PAcKage

The LFPAK package was developed as a ‘true’ power package; the package design has been optimised to give the best thermal & electrical performance, cost and reliability.

### Package resistance (mOhm)

<table>
<thead>
<tr>
<th>Package</th>
<th>Resistance (mOhm)</th>
</tr>
</thead>
<tbody>
<tr>
<td>LFPAK</td>
<td>0.5</td>
</tr>
<tr>
<td>D2PAK</td>
<td>1.0</td>
</tr>
<tr>
<td>TO220</td>
<td>1.5</td>
</tr>
<tr>
<td>DPAK</td>
<td>2.0</td>
</tr>
</tbody>
</table>

### LFPAK construction

The silicon die is soldered to the DRAIN tab forming the electrical DRAIN connection and a low thermal resistance path to the PCB. The top-clip is then soldered to the silicon die to provide SOURCE and GATE connections, eliminating the gold-wires and reducing package resistance and inductance.

The DRAIN tab is soldered directly to the PCB to provide a low electrical resistance and also low thermal resistance between the MOSFET and PCB.
MOSFET assembly techniques of competitor devices

Compare the LFPAK with competitor Power-SO8 types which are often constructed using wire or ribbon bonding as shown below. LFPAK uses a combined copper clip which is soldered in a single operation to the GATE & SOURCE. This reduces the spreading resistance, which is seen when bond wires are used and gives LFPAK superior electrical & thermal performance as well as increased reliability when compared to many competitor Power-SO8 types.

LFPAK eliminates wire-bonding seen in many competitor devices
LFPAK Combined GATE & SOURCE clip with soldered die-attach gives:
- maximum mechanical ruggedness & reliability
- lowest electrical resistance
- lowest thermal resistance
- simplified manufacturing process
Customer feedback consistently shows that LFPAK is more reliable & rugged than competitor 5x6mm QFN & micro-lead devices. The following diagram shows that mechanical stress can occur when a device is rapidly heated or cooled causing cracking of the MOSFET moulding and also solder joint failure under the GATE & SOURCE pins of a QFN device. LFPAK’s construction allows the SOURCE & GATE pins to ‘flex’ and safely absorb any stress. Similar stresses on a QFN or micro-lead device often causes solder joint failures and/or cracking of the plastic case which can lead to failures.

LFPAK is the only Power-SO8 device available with automotive qualification (AEC-Q101) which is clear proof of its superior ruggedness & reliability under the toughest conditions.

Diagnosis & failure for QFN & micro-lead devices often requires costly X-ray analysis and specialist SMT rework equipment. LFPAK solder joints can be visually inspected and it is possible to rework an LFPAK device using simple, low-cost rework tools.

Mechanical stresses occur when a SMT device is subject to rapid temperature change or if the PCB bends due to mechanical strain or vibration.

The LFPAK’s exposed lead-frame provides compliance and allows for movement due to thermal expansion and mechanical strain.

QFN sawn & micro-lead packages are fully encapsulated and do not allow for movement due to thermal expansion or mechanical strain. Mechanical & thermal stresses lead to solder-joint failures at the GATE & SOURCE pins.

Also cracking can occur in the mould material around the pins which can lead to moisture ingress & ionic contamination causing degradation & early failure of the MOSFET.
The thermal performance of a MOSFET when mounted to a PCB relies on two parameters.

**Rth(j-mb) thermal resistance – junction to mounting base**

For LFPAK and TO220 packages Rth(j-mb) is quoted on the datasheets and is typically 0.5 C/W to 2 C/W. This value depends on the chip size for the silicon and generally increases as the silicon size decreases.

**Rth(j-a) thermal resistance – mounting base to ambient**

This value is quoted for TO220 devices and is not quoted for LFPAK devices – why is this?

For TO220 devices, Rth(j-a) represents the thermal resistance between the MOSFET junction and ambient (not connected to a heatsink). Rth(j-a) represents a free-standing TO220 device and can be easily measured & characterised. Since it is possible to mount & operate a TO220 device without a heatsink, then Rth(j-a) is useful for calculating the junction temperature and/or the maximum allowable power dissipation for a free-standing TO220 device.

For LFPAK devices, the MOSFET’s DRAIN connection to the circuit relies on it being soldered to a PCB, it is not possible to operate an LFPAK MOSFET in free-standing mode like a TO220 device. Therefore the thermal resistance Rth(j-a) for the MOSFET on its own is not meaningful and cannot be measured. The thermal resistance should be approximated to the following expression (ignoring any radiation & convection losses of the MOSFET).

\[
R_{th}(j-a) = R_{th}(j-mb) + R_{th}(mb-a)
\]

Since Rth(j-mb) is typically approx 1 C/W then the thermal performance is dominated by the thermal resistance of the PCB Rth(mb-a) which varies widely and can be 40 - 100 times greater than the Rth(j-mb).

The graph shows Rth(j-a) for a 40 mm x 40 mm FR4 PCB. The simulation is for a simplified single LFPAK MOSFET mounted to a copper footprint with dimensions length = width = x

The graph shows that the thermal performance is dependent on copper pad size and also the number and type of copper layers in the PCB.
Illustrates the PCB dimensions used for thermal simulation.

Illustrates the use of thermal vias between layer-1 and layer-4, to optimise the conduction of heat away from the LFPAK device.
LFPAK soldering & footprint compatibility

- There are many power MOSFETs available in the power-SO8 family. The following diagram shows that the package styles and recommended PCB footprints differ significantly from each manufacturer. There is no generic JEDEC standard for Power-SO8 devices and therefore each device generally has a different PCB footprint as illustrated below.
- None of the manufacturers devices are guaranteed to be interchangeable with other devices.

LFPAK (SOT669 & SOT1023) achieves mechanical & electrical compatibility with the following Power-SO8 types. Each variant may require a different solder-resist, solder-stencil and machine programming unless careful consideration has been made in advance to design a universal footprint which will allow multiple devices to be fitted to the PCB.
- The following diagram shows each manufacturers original footprint with their Power-SO8 mounted on it. The diagram below shows the manufacturers footprint with an LFPAK mounted.

The diagram above shows that the LFPAK will provide basic electrical and mechanical compatibility with other manufacturers Power-SO8 package footprint. Care must be taken to correctly specify the solder resist layer and solder stencil.
Through careful design of the PCB footprint, it is possible to design a universal footprint, such as the one shown below, that meets the requirements of various PowerSO8 manufacturers. The example universal footprint shows the solder resist & solder stencil details, which allow a PCB designer to create a footprint that is compatible with all of the following power-SO8 types.

Recommended universal Power-SO8 & LFPAK footprint allows the following device types to be mounted to a single PCB design:

- **NXP LFPAK** (SOT669 & SOT1023)
- **Infineon** PG-TDSON-8
- **Fairchild** Power 56
- **Vishay** PowerPAK SO-8
- **NEC** 8-pin HVSON
- **ON Semi** SO-8 FL
- **STM** PowerFLAT (6x5)
- **Renesas** LFPAK
